Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/053,229	CHANG ET AL.	
Examiner	Art Unit	
Annan Q. Shang	2617	•

SEARCHED				
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Class	Subclass	Date	Examiner	
725	95,120,13 3,141,153	2/1/2006	A.S	
375	240.26	2/1/2006	A.S	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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